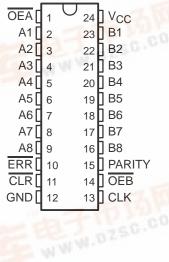
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- BiCMOS Process With TTL Inputs and Outputs
- BiCMOS Design Reduces Standby Current
- Flow-Through Pinout (All Inputs on Opposite Side From Outputs)
- Functionally Equivalent to SN74ALS29834 and AMD Am29834
- High-Speed Bus Transceiver With Parity Generator/Checker
- Parity-Error Flag With Open-Collector Output
- Available Register For Storage of the Parity-Error Flag
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic 300-mil DIPs (NT)

#### DW OR NT PACKAGE (TOP VIEW)



#### description

The SN74BCT29834 is an 8-bit to 9-bit parity transceiver designed for asynchronous communication between data buses. When data is transmitted from the A to B bus, a parity bit is generated. When data is transmitted from the B to A bus with its corresponding parity bit, the parity-error (ERR) output will indicate whether or not an error in the B data has occurred. The output-enable (OEA, OEB) inputs can be used to disable the device so that the buses are effectively isolated.

A 9-bit parity generator/checker generates a parity-odd (PARITY) output and monitors the parity of the I/O ports with an open-collector parity-error flag (ERR). ERR is clocked into the register on the rising edge of the CLK input. The error flag register is cleared with a low pulse on the clear (CLR) input. When both OEA and OEB are low, data is transferred from the A bus to the B bus and inverted parity is generated. Inverted parity is a forced error condition which gives the designer more system diagnostic capability. The SN74BCT29834 provides inverting logic.

The SN74BCT29834 is characterized for operation from 0°C to 70°C.

#### **FUNCTION TABLE**

No.	INPUTS				OUTPUT AND I/O					
OEB	OEA	CLR	CLK	Ai ∑ of H's	Bi <sup>†</sup> ∑ of L's	Α	В	PARITY	ERR‡	FUNCTION
L	Н	Χ	Χ	Odd Even	NA	NA	Ā	H	NA	A data to B bus and generate parity
Н	L	Н	1	NA	Odd Even	B	NA	NA	H L	B data to A bus and check parity
Х	X	L	Χ	Χ	X	Х	NA	NA	Н	Clear error-flag register
Н	Н	H L H	No↑ No↑ ↑	X X Odd Even	25 X .CC	Z	Z	Z	NC H L H	Isolation§
-10%	L	Х	Х	Odd Even	NA	NA	Ā	L H	NA	Ā data to B bus and generate inverted parity

NA = not applicable, NC = no change, X = don't care

<sup>§</sup> In this mode, the ERR output, when enabled, shows inverted parity of the A bus.



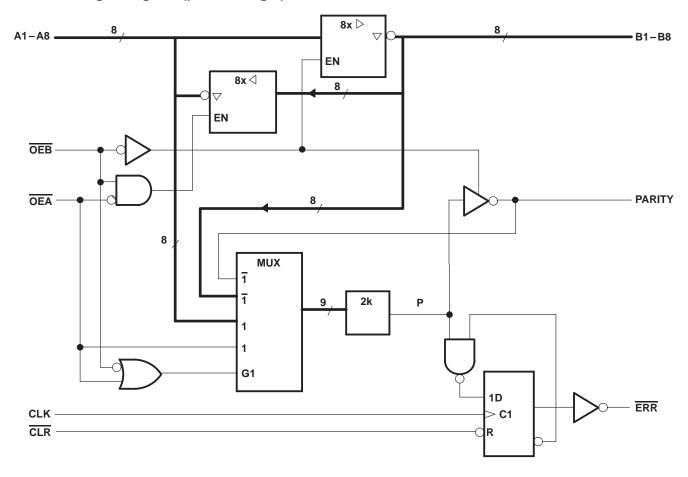
<sup>†</sup>Summation of high-level inputs includes PARITY along with Bi inputs.

<sup>‡</sup> Output states shown assume the ERR output was previously high.

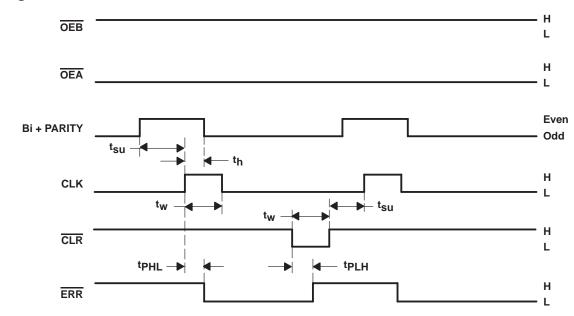
## SN74BCT29834 8-BIT TO 9-BIT PARITY BUS TRANSCEIVER

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## functional logic diagram (positive logic)



### error-flag waveforms



#### **ERROR-FLAG FUNCTION TABLE**

INPUTS		INTERNAL TO DEVICE	OUTPUT PRESTATE	OUTPUT	FUNCTION		
CLR	CLK	POINT P	ERR <sub>n-1</sub> †	ERR			
H H H		H X L	H L X	H L L	Sample		
L	Х	X	Х	Н	Clear		

† ERR<sub>n-1</sub> represents the state of the ERR output before any changes at CLR, CLK, or point P.

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V <sub>CC</sub>	 7 V
Input voltage, V <sub>I</sub>	 7 V
Voltage applied to a disabled I/O port	 5.5 V
Operating free-air temperature range	 0°C to 70°C
Storage temperature range	 $-65^{\circ}\text{C}$ to $150^{\circ}\text{C}$

<sup>&</sup>lt;sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



## SN74BCT29834 8-BIT TO 9-BIT PARITY BUS TRANSCEIVER

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#### recommended operating conditions

		MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
VIL	Low-level input voltage			0.8	V
Vон	High-level output voltage, ERR			2.4	V
loh	High-level output current			-24	mA
loL	Low-level output current			48	mA
TA	Operating free-air temperature	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	Т	MIN TY	YPT MAX	UNIT	
٧ıK		$V_{CC} = 4.5 \text{ V},$	I <sub>I</sub> = -18 mA		-1.2	V
Vall	All inputs (sutputs except EDD	V <sub>CC</sub> = 4.5 V	$I_{OH} = -15 \text{ mA}$	2.4		
VOH	All inputs/outputs except ERR	VCC = 4.5 V	$I_{OH} = -24 \text{ mA}$	2		]
IOH	ERR	$V_{CC} = 4.5 \text{ V},$	V <sub>OH</sub> = 2.4 V		20	μΑ
VOL		$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 48 \text{ mA}$	C	0.5	V
Ц		$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 5.5 V		0.1	mA
I <sub>IH</sub> ‡		$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 2.7 V		20	μΑ
. +	Data	VCC = 5.5 V,	V <sub>I</sub> = 0.4 V		-0.2	mA
I <sub>IL</sub> ‡	Control	VCC = 5.5 v,	V  = 0.4 V		-0.75	] IIIA
los§		$V_{CC} = 5.5 \text{ V},$	VO = 0	<b>–75</b>	-250	mA
ICCL		$V_{CC} = 5.5 \text{ V},$	Outputs open		55 80	mA
Iccz		$V_{CC} = 5.5 \text{ V},$	Outputs open		30 45	mA

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

## timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

				MIN	MAX	UNIT
	CLK high					
t <sub>W</sub>	Pulse duration		CLK low	10		ns
	CLR low					
l.	Catura time a h afarra CLIVA	B		12		ne
t <sub>su</sub>	Setup time before CLK↑		CLR inactive	12		ns
th	Hold time after CLK↑		Bi and PARITY	0		ns



<sup>‡</sup> These parameters include off-state output current for I/O ports only.

<sup>§</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

## SN74BCT29834 8-BIT TO 9-BIT PARITY BUS TRANSCEIVER

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# switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L$ = 50 pF (unless otherwise noted) (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	CL R1 R2	C = 5 V, = 50 pF = 500 Ω = 500 Ω = 25°C	,	$\label{eq:VCC} \begin{split} &\text{V}_{\text{CC}} = 4.5  \text{V} \\ &\text{C}_{\text{L}} = 50  \text{pp} \\ &\text{R1} = 500  \Omega \\ &\text{R2} = 500  \Omega \\ &\text{T}_{\text{A}} = \text{MIN to} \\ &\text{MIN} \end{split}$	, ,	UNIT
<sup>t</sup> PLH	A or B	B or A	1	5	7	1	8	ns
t <sub>PHL</sub>	AUID	D OF A	1.5	4	6	1.5	7	
t <sub>PLH</sub>	А	PARITY	1.5	10	13	1.5	15	ns
<sup>t</sup> PHL		PARIT	1.5	8	10	1.5	15	
<sup>t</sup> PZH	OEA or OEB	A or B	2	11	15	2	19	ns
t <sub>PZL</sub>	OEA OI OEB	AOIB	2	15	19	2	21	113
<sup>t</sup> PHZ	OEA or OEB	A or B	2	8	11	2	15	ns
<sup>t</sup> PLZ	OEA OI OEB	AOIB	2	13	17	2	21	115
4	CLK		1.5	7	10	1.5	12	
<sup>t</sup> PLH	CLR	ERR	1.5	13	17	1.5	18	ns
<sup>t</sup> PLH	ŌĒĀ	PARITY	1.5	10	13	1.5	15	ne
<sup>t</sup> PHL	OEA	FAMILI	1.5	10	13	1.5	15	ns

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 1: Load circuits and voltage waveforms are shown in Section 1.

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